

**PowerMOS transistor****BUK456-100A/B****GENERAL DESCRIPTION**

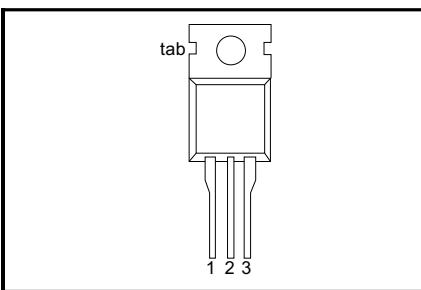
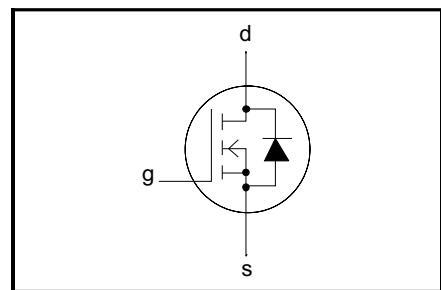
N-channel enhancement mode field-effect power transistor in a plastic envelope.  
The device is intended for use in Switched Mode Power Supplies (SMPS), motor control, welding, DC/DC and AC/DC converters, and in general purpose switching applications.

**QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	MAX.	UNIT
$V_{DS}$	Drain-source voltage	-100A	-100B	V
$I_D$	Drain current (DC)	100	100	A
$P_{tot}$	Total power dissipation	34	32	W
$T_j$	Junction temperature	150	150	°C
$R_{DS(ON)}$	Drain-source on-state resistance	175	175	Ω
		0.057	0.065	

**PINNING - TO220AB**

PIN	DESCRIPTION
1	gate
2	drain
3	source
tab	drain

**PIN CONFIGURATION****SYMBOL****LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DS}$ $V_{DGR}$ $\pm V_{GS}$	Drain-source voltage	$R_{GS} = 20 \text{ k}\Omega$	-	100	V
	Drain-gate voltage		-	100	V
	Gate-source voltage		-	30	V
$I_D$ $I_D^P$ $I_{DM}$	Drain current (DC)	$T_{mb} = 25 \text{ }^\circ\text{C}$ $T_{mb} = 100 \text{ }^\circ\text{C}$ $T_{mb} = 25 \text{ }^\circ\text{C}$	-	34	A
	Drain current (DC)		-	24	A
	Drain current (pulse peak value)		-	136	A
$P_{tot}$ $T_{stg}$ $T_j$	Total power dissipation	$T_{mb} = 25 \text{ }^\circ\text{C}$	-	150	W
	Storage temperature		-55	175	°C
	Junction temperature		-	175	°C

**THERMAL RESISTANCES**

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$R_{th j-mb}$	Thermal resistance junction to mounting base		-	-	1.0	K/W
$R_{th j-a}$	Thermal resistance junction to ambient		-	60	-	K/W

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**STATIC CHARACTERISTICS** $T_{mb} = 25^\circ C$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 V; I_D = 0.25 \text{ mA}$	100	-	-	V
$V_{GS(TO)}$	Gate threshold voltage	$V_{DS} = V_{GS}; I_D = 1 \text{ mA}$	2.1	3.0	4.0	V
$I_{DSS}$	Zero gate voltage drain current	$V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25^\circ C$	-	1	10	$\mu\text{A}$
$I_{DSS}$	Zero gate voltage drain current	$V_{DS} = 100 V; V_{GS} = 0 V; T_j = 125^\circ C$	-	0.1	1.0	mA
$I_{GSS}$	Gate source leakage current	$V_{GS} = \pm 30 V; V_{DS} = 0 V$	-	10	100	nA
$R_{DS(ON)}$	Drain-source on-state resistance	$V_{GS} = 10 V; I_D = 15 A$	BUK456-100A	-	0.052	0.057
			BUK456-100B	-	0.06	0.065

**DYNAMIC CHARACTERISTICS** $T_{mb} = 25^\circ C$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$g_{fs}$	Forward transconductance	$V_{DS} = 25 V; I_D = 15 A$	12	16	-	S
$C_{iss}$	Input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 \text{ MHz}$	-	1500	2000	pF
$C_{oss}$	Output capacitance		-	450	600	pF
$C_{rss}$	Feedback capacitance		-	130	200	pF
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 30 V; I_D = 3 A;$	-	20	30	ns
$t_r$	Turn-on rise time	$V_{GS} = 10 V;$	-	40	60	ns
$t_{d(off)}$	Turn-off delay time	$R_{gen} = 50 \Omega;$	-	150	200	ns
$t_f$	Turn-off fall time	$R_{GS} = 50 \Omega$	-	65	85	ns
$L_d$	Internal drain inductance	Measured from contact screw on tab to centre of die	-	3.5	-	nH
$L_d$	Internal drain inductance	Measured from drain lead 6 mm from package to centre of die	-	4.5	-	nH
$L_s$	Internal source inductance	Measured from source lead 6 mm from package to source bond pad	-	7.5	-	nH

**REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS** $T_{mb} = 25^\circ C$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$I_{DR}$	Continuous reverse drain current	-	-	-	34	A
$I_{DRM}$	Pulsed reverse drain current	-	-	-	136	A
$V_{SD}$	Diode forward voltage	$I_F = 34 A; V_{GS} = 0 V$	-	1.8	2.5	V
$t_{rr}$	Reverse recovery time	$I_F = 34 A; -dI_F/dt = 100 A/\mu s;$	-	100	-	ns
$Q_{rr}$	Reverse recovery charge	$V_{GS} = 0 V; V_R = 30 V$	-	1.0	-	$\mu C$

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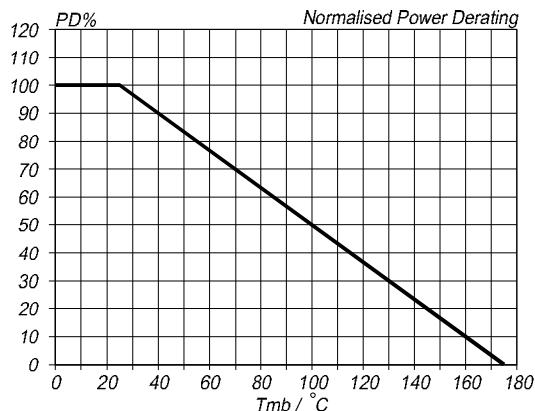


Fig. 1. Normalised power dissipation.  
 $PD\% = 100 P_D/P_{D,25\text{ }^{\circ}\text{C}} = f(T_{mb})$

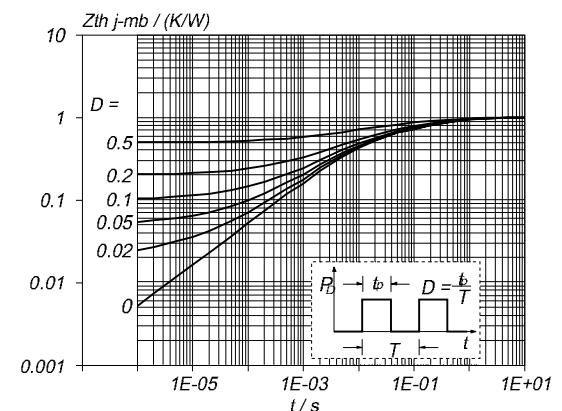


Fig. 4. Transient thermal impedance.  
 $Z_{th,j-mb} = f(t); \text{parameter } D = t_p/T$

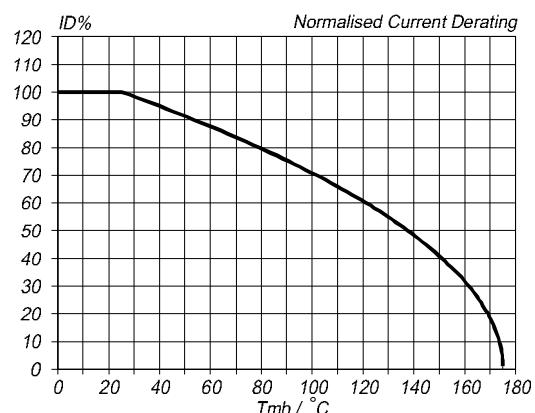


Fig. 2. Normalised continuous drain current.  
 $ID\% = 100 I_D/I_{D,25\text{ }^{\circ}\text{C}} = f(T_{mb}); \text{conditions: } V_{GS} \geq 10 \text{ V}$

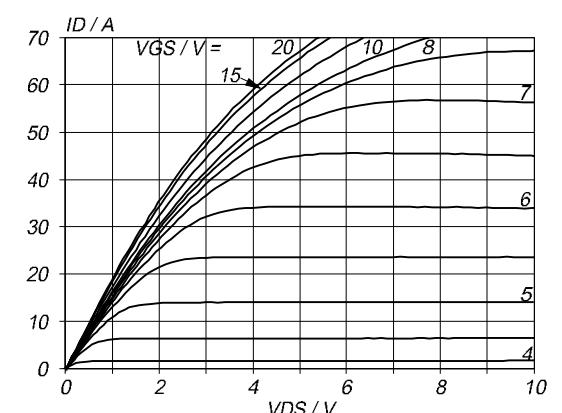


Fig. 5. Typical output characteristics,  $T_j = 25 \text{ }^{\circ}\text{C}$ .  
 $I_D = f(V_{DS}); \text{parameter } V_{GS}$

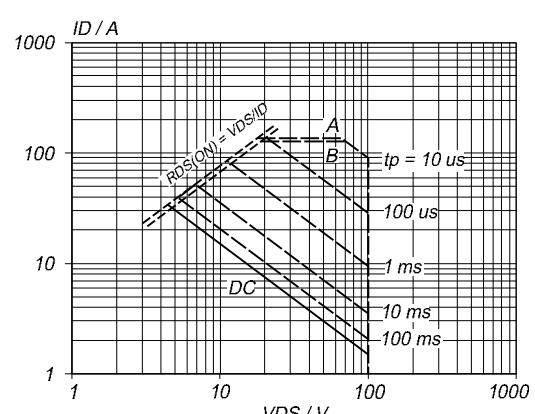


Fig. 3. Safe operating area,  $T_{mb} = 25 \text{ }^{\circ}\text{C}$   
 $I_D \& I_{DM} = f(V_{DS}); I_{DM} \text{ single pulse}; \text{parameter } t_p$

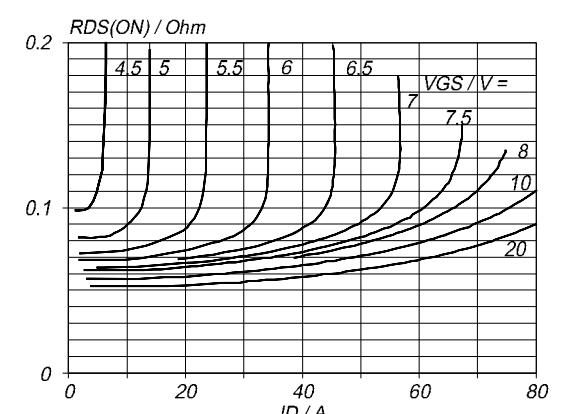


Fig. 6. Typical on-state resistance,  $T_j = 25 \text{ }^{\circ}\text{C}$ .  
 $R_{DS(ON)} = f(I_D); \text{parameter } V_{GS}$

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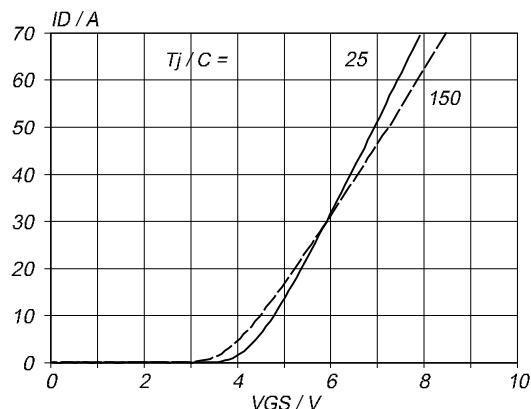


Fig. 7. Typical transfer characteristics.  
 $I_D = f(V_{GS})$ ; conditions:  $V_{DS} = 25$  V; parameter  $T_j$

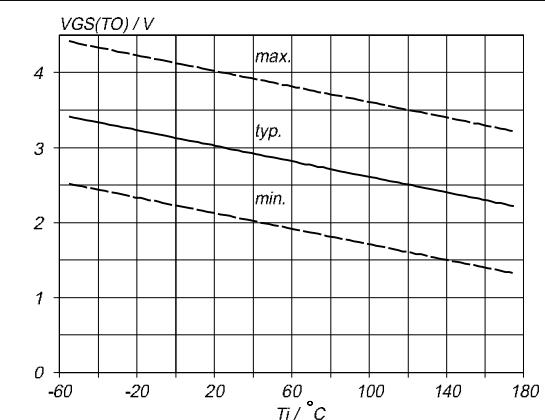


Fig. 10. Gate threshold voltage.  
 $V_{GS(TO)} = f(T_j)$ ; conditions:  $I_D = 1$  mA;  $V_{DS} = V_{GS}$

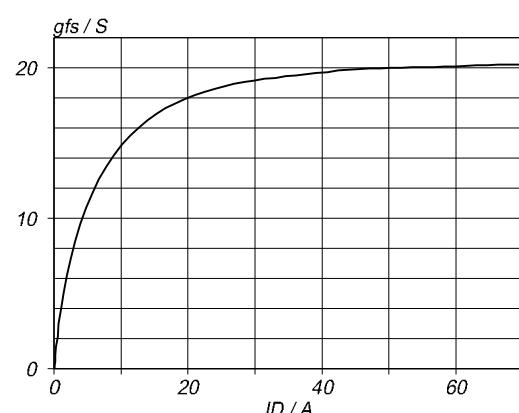


Fig. 8. Typical transconductance,  $T_j = 25$  °C.  
 $g_{fs} = f(I_D)$ ; conditions:  $V_{DS} = 25$  V

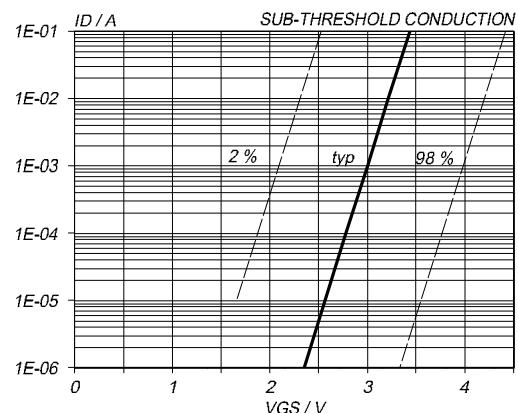


Fig. 11. Sub-threshold drain current.  
 $I_D = f(V_{GS})$ ; conditions:  $T_j = 25$  °C;  $V_{DS} = V_{GS}$

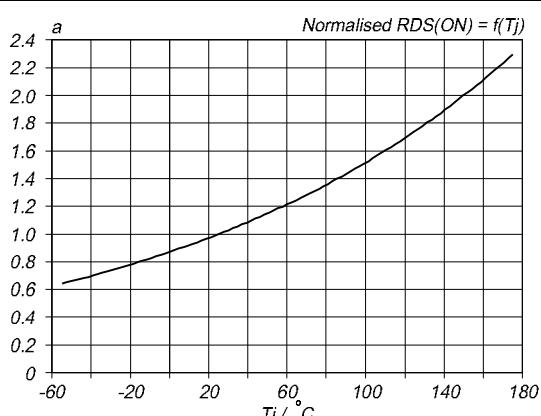


Fig. 9. Normalised drain-source on-state resistance.  
 $a = R_{DS(ON)}/R_{DS(ON)25\text{ }^{\circ}\text{C}} = f(T_j)$ ;  $I_D = 15$  A;  $V_{GS} = 10$  V

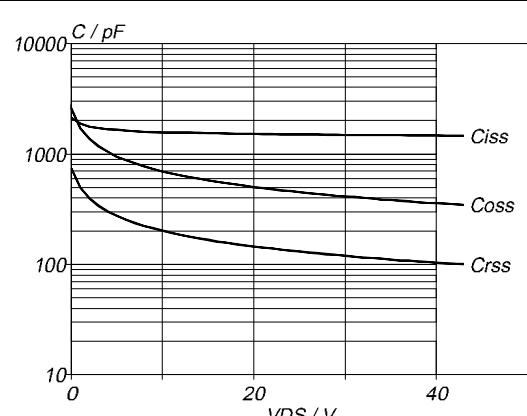


Fig. 12. Typical capacitances,  $C_{iss}$ ,  $C_{oss}$ ,  $C_{rss}$ .  
 $C = f(V_{DS})$ ; conditions:  $V_{GS} = 0$  V;  $f = 1$  MHz

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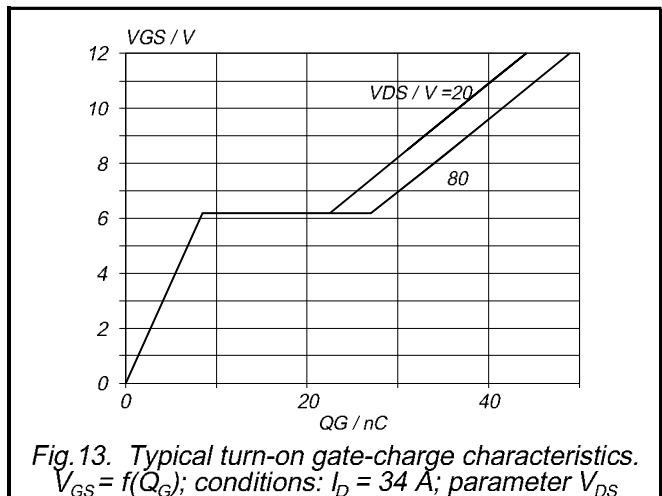


Fig. 13. Typical turn-on gate-charge characteristics.  
 $V_{GS} = f(Q_G)$ ; conditions:  $I_D = 34 \text{ A}$ ; parameter  $V_{DS}$

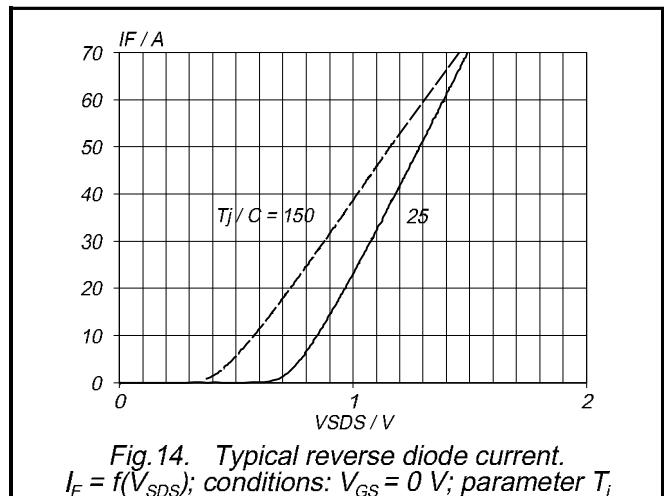


Fig. 14. Typical reverse diode current.  
 $I_F = f(V_{SDS})$ ; conditions:  $V_{GS} = 0 \text{ V}$ ; parameter  $T_j$

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**MECHANICAL DATA***Dimensions in mm*

Net Mass: 2 g

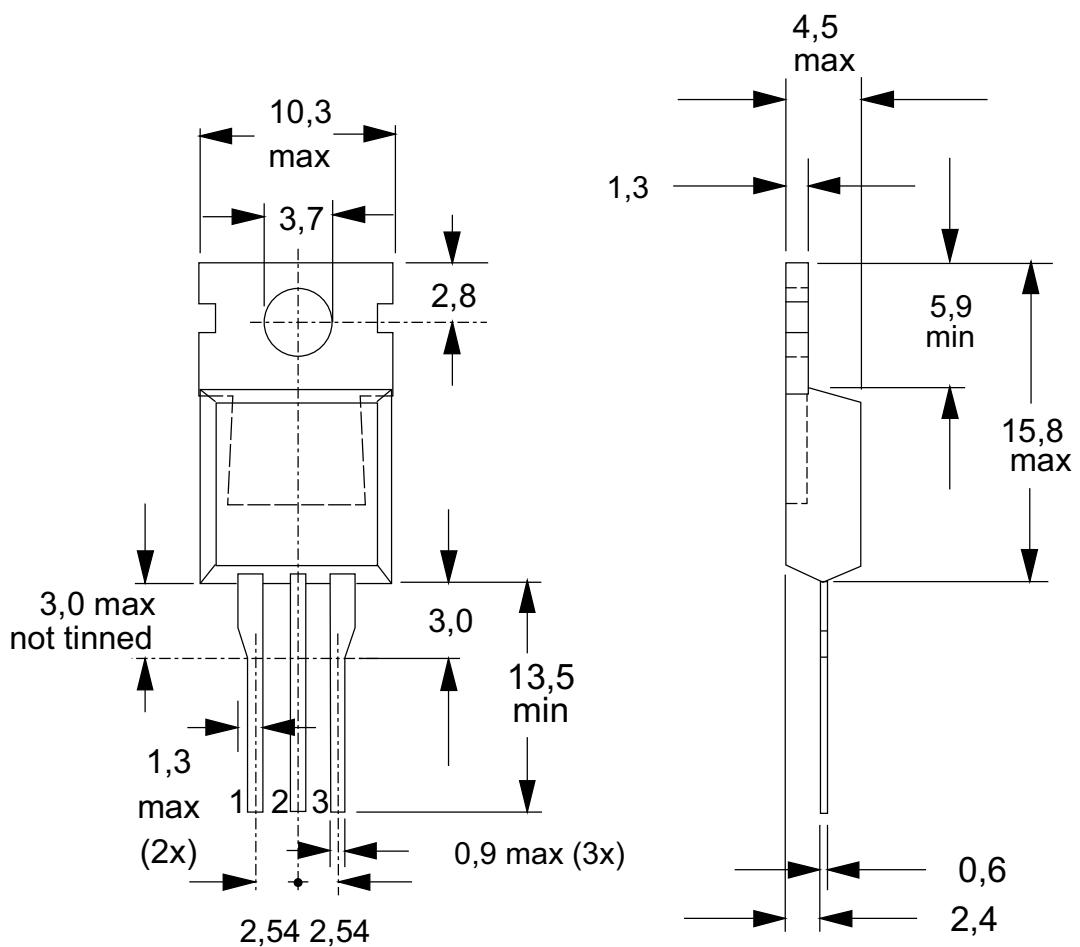


Fig.15. SOT78 (TO220AB); pin 2 connected to mounting base.

**Notes**

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Refer to mounting instructions for SOT78 (TO220) envelopes.
3. Epoxy meets UL94 V0 at 1/8".

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**DEFINITIONS**

<b>Data sheet status</b>	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
<b>Limiting values</b>	
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
<b>Application information</b>	
Where application information is given, it is advisory and does not form part of the specification.	
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